Old Company Name in Catalogs and Other Documents

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Renesas Electronics website: http://www.renesas.com

April 1st, 2010 Renesas Electronics Corporation

Issued by: Renesas Electronics Corporation (http://www.renesas.com)

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DATA SHEET



MOS FIELD EFFECT TRANSISTOR μ PA2791GR

SWITCHING N- AND P-CHANNEL POWER MOS FET

DESCRIPTION

The μ PA2791GR is N- and P-channel MOS Field Effect Transistors designed for switching application.

FEATURES

• Low on-state resistance

N-channel R_{DS(on)1} = 36.0 m Ω MAX. (V_{GS} = 10 V, I_D = 3.0 A)

 $R_{DS(on)2} = 50.0 \text{ m}\Omega \text{ MAX.} \text{ (Vgs = 4.5 V, ID = 3.0 A)}$

P-channel R_{DS(on)1} = 82 m Ω MAX. (V_{GS} = -10 V, I_D = -3.0 A)

 $R_{DS(on)2} = 110 \text{ m}\Omega \text{ MAX}. \text{ (V}_{GS} = -4.5 \text{ V}, I_{D} = -3.0 \text{ A)}$

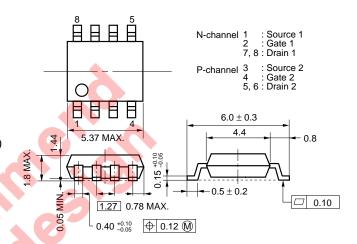
· Low gate charge

N-channel Q_G = 10 nC TYP. (V_{GS} = 10 V)

P-channel Qg = 8.3 nC TYP. (Vgs = -10 V)

- Built-in gate protection diode
- Small and surface mount package (Power SOP8)

PACKAGE DRAWING (Unit: mm)

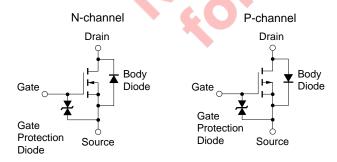


ORDERING INFORMATION

PART NUMBER	LEAD PLATING	PACKING	PACKAGE
μPA2791GR-E1-AT Note	Pure Sn	Tape 2500	Power SOP8
μPA2791GR-E2-AT Note	Fule 311	p/reel	Fowel SOF6

Note Pb-free (This product does not contain Pb in the external electrode and other parts.)

EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

Caution This product is electrostatic-sensitive device due to low ESD capability and should be handled with caution for electrostatic discharge. VESD \pm 600 V TYP. (C = 100 pF, R = 1.5 k Ω)

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<R>

ABSOLUTE MAXIMUM RATINGS (TA = 25°C. All terminals are connected.)

	-		•	
PARAMETER	SYMBOL	N-CHANNEL	P-CHANNEL	UNIT
Drain to Source Voltage (V _{GS} = 0 V)	V _{DSS}	30	-30	V
Gate to Source Voltage (V _{DS} = 0 V)	V _{GSS}	±20	∓20	V
Drain Current (DC) (Tc = 25°C) Note2	I _{D(DC)}	±5	∓5	Α
Drain Current (pulse) Note1	ID(pulse)	±20	∓20	А
Total Power Dissipation (1 unit) Note2	P _{T1}	1.7	W	
Total Power Dissipation (2 units) Note2	P _{T2}	2.0	W	
Channel Temperature	Tch	150		°C
Storage Temperature	T _{stg}	-55 to +150		°C
Single Avalanche Current Note3	las	5	-5	А
Single Avalanche Energy Note3	Eas	2.5		mJ

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Mounted on ceramic substrate of 2000 mm² x 1.6 mmt

<R> 3. Starting Tch = 25°C, Vdd = 1/2 x Vdss, Rg = 25 Ω , L = 100 μ H, Vgs = Vgss \rightarrow 0 V



ELECTRICAL CHARACTERISTICS (TA = 25°C. All terminals are connected.)

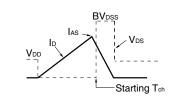
N-channel

N-Chamile						
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 30 V, V _{GS} = 0 V			10	μΑ
Gate Leakage Current	Igss	V _{GS} = ±16 V, V _{DS} = 0 V			±10	μΑ
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.0		2.5	V
Forward Transfer Admittance Note	yfs	V _{DS} = 10 V, I _D = 3 A	2.0			S
Drain to Source On-state Resistance Note	RDS(on)1	V _{GS} = 10 V, I _D = 3.0 A		28.5	36.0	mΩ
	RDS(on)2	V _{GS} = 4.5 V, I _D = 3.0 A		36.0	50.0	mΩ
Input Capacitance	Ciss	V _{DS} = 10 V,		400		pF
Output Capacitance	Coss	V _{GS} = 0 V,		80		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		50		pF
Turn-on Delay Time	t _{d(on)}	V _{DD} = 15 V, I _D = 3 A,		7		ns
Rise Time	t r	V _{GS} = 10 V,		4		ns
Turn-off Delay Time	td(off)	R _G = 10 Ω	0	21		ns
Fall Time	t f			5		ns
Total Gate Charge	Q _G	ID = 5 A,		10		nC
Gate to Source Charge	Qgs	V _{DD} = 24 V,		1.5		nC
Gate to Drain Charge	Q _{GD}	V _{GS} = 10 V		2.7		nC
Body Diode Forward Voltage Note	V _F (S-D)	I _F = 5 A, V _{GS} = 0 V		0.86		V
Reverse Recovery Time	trr	I _F = 5 A, V _{GS} = 0 V,		20		ns
Reverse Recovery Charge	Qrr	di/dt = 50 A/μs		16		nC

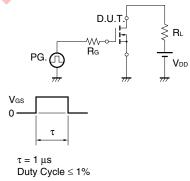
Note Pulsed

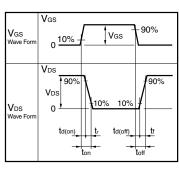
<R> TEST CIRCUIT 1 AVALANCHE CAPABILITY

$\begin{array}{c} \text{D.U.T.} \\ \text{Rg} = 25 \, \Omega \\ \text{V}_{\text{GS}} = 20 \rightarrow 0 \, \text{V} \end{array}$



TEST CIRCUIT 2 SWITCHING TIME





TEST CIRCUIT 3 GATE CHARGE



P-channel

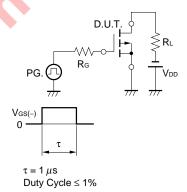
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = -30 V, V _{GS} = 0 V			-10	μΑ
Gate Leakage Current	Igss	V _{GS} = ∓16 V, V _{DS} = 0 V			∓10	μΑ
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = -10 V, I _D = -1 mA	-1.0		-2.5	V
Forward Transfer Admittance Note	y _{fs}	V _{DS} = -10 V, I _D = -3 A	1.0			S
Drain to Source On-state Resistance Note	R _{DS(on)1}	V _{GS} = -10 V, I _D = -3.0 A		63	82	mΩ
	R _{DS(on)2}	V _{GS} = -4.5 V, I _D = -3.0 A		79	110	mΩ
Input Capacitance	Ciss	V _{DS} = -10 V,		300		pF
Output Capacitance	Coss	V _G S = 0 V,		75		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		60		pF
Turn-on Delay Time	t _{d(on)}	V _{DD} = -15 V, I _D = -3 A,		8		ns
Rise Time	tr	V _{GS} = -10 V,		14		ns
Turn-off Delay Time	t _{d(off)}	R _G = 10 Ω		50		ns
Fall Time	tf		5	40		ns
Total Gate Charge	Q _G	I _D = -5 A,		8.3		nC
Gate to Source Charge	Qgs	V _{DD} = -24 V,		1.2		nC
Gate to Drain Charge	Q _{GD}	V _{GS} = -10 V		2.4		nC
Body Diode Forward Voltage Note	V _{F(S-D)}	I _F = 5 A, V _{GS} = 0 V		0.96		V
Reverse Recovery Time	trr	I _F = 5 A, V _{GS} = 0 V,		37		ns
Reverse Recovery Charge	Qrr	di/dt = 50 A/μs		29		nC

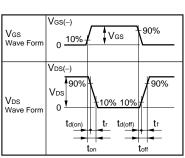
Note Pulsed

<R> TEST CIRCUIT 1 AVALANCHE CAPABILITY

$PG. \square > 50 \Omega$ $V_{GS} = -20 \rightarrow 0 \text{ V} \square \square$ V_{DD} V_{DD} V_{DD} $Starting T_{ch}$

TEST CIRCUIT 2 SWITCHING TIME



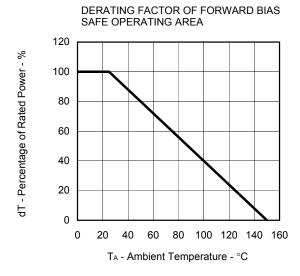


TEST CIRCUIT 3 GATE CHARGE

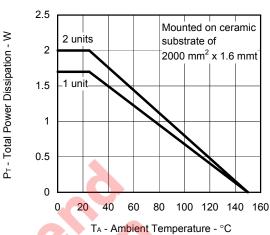
$$\begin{array}{c|c} D.U.T. \\ \hline \\ IG = -2 \text{ mA} \\ \hline \\ PG. \\ \hline \\ \end{array}$$

TYPICAL CHARACTERISTICS (TA = 25°C)

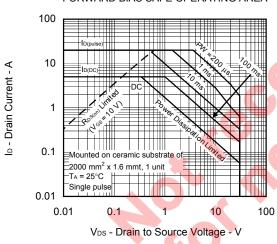
(1) N-channel



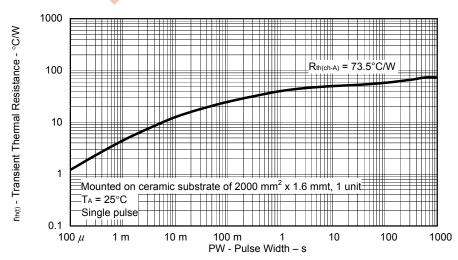
TOTAL POWER DISSIPATION vs. AMBIENT TEMPERATURE

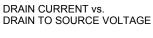


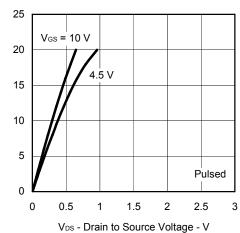




TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

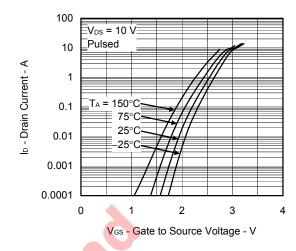




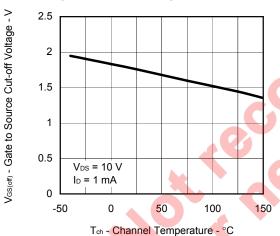


lo - Drain Current - A

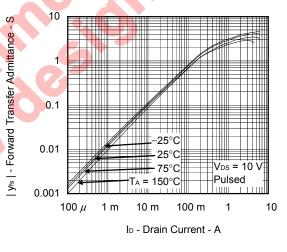
FORWARD TRANSFER CHARACTERISTICS



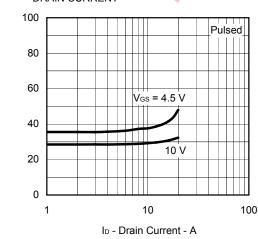
GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



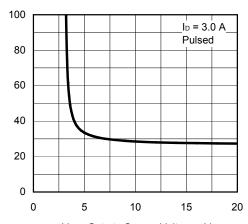
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

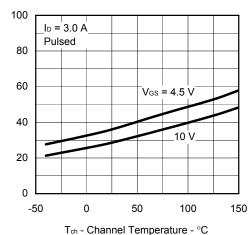


V_{GS} - Gate to Source Voltage - V

R_{DS(on)} - Drain to Source On-state Resistance - mΩ

R_{DS(on)} - Drain to Source On-state Resistance - mΩ

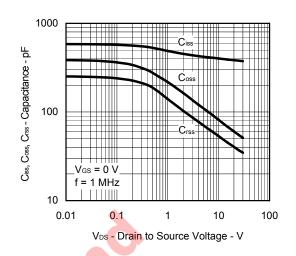




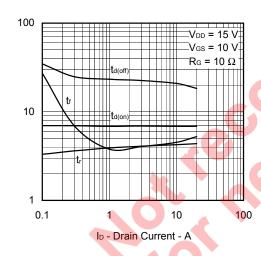
R_{DS(on)} - Drain to Source On-state Resistance - mΩ

ta(on), tr, ta(off), tr - Switching Time - ns

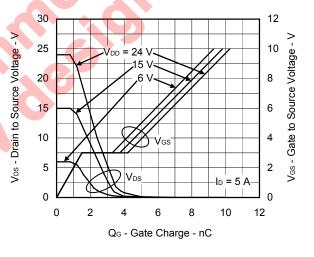
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



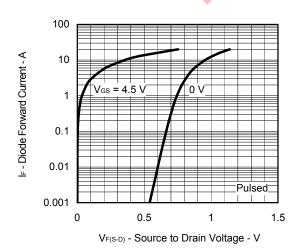
SWITCHING CHARACTERISTICS



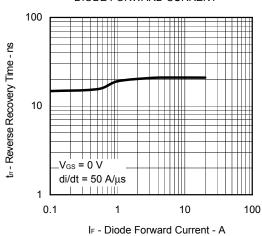
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



SOURCE TO DRAIN DIODE FORWARD VOLTAGE

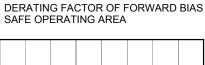


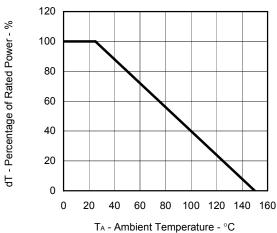
REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT



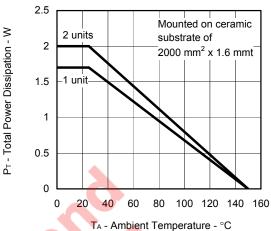
NEC μ PA2791GR

(2) P-channel

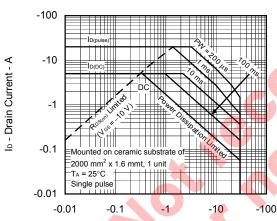




TOTAL POWER DISSIPATION vs. AMBIENT TEMPERATURE 2.5

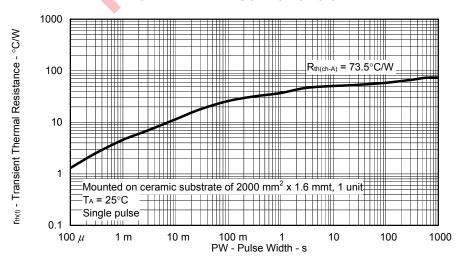


FORWARD BIAS SAFE OPERATING AREA

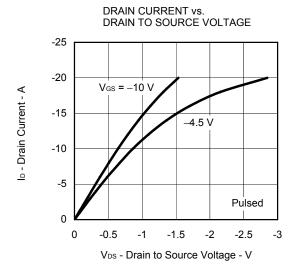


V_{DS} - Drain to Source Voltage - V

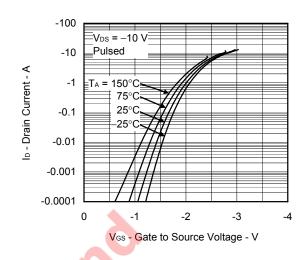
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

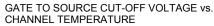


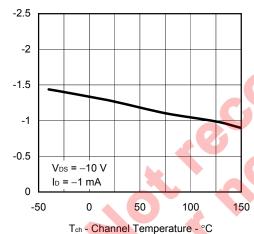
NEC μ PA2791GR







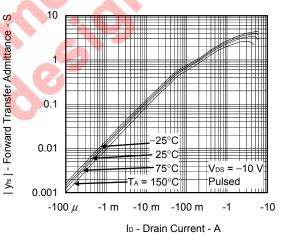




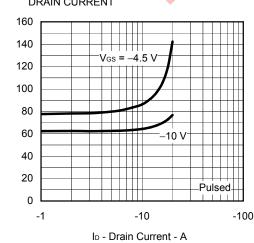
VGS(Off) - Gate to Source Cut-off Voltage - V

RDS(m) - Drain to Source On-state Resistance - m\Omega

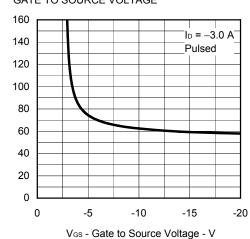
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



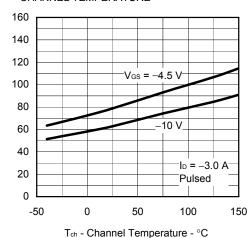
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



R_{DS(m)} - Drain to Source On-state Resistance - mΩ

NEC μ PA2791GR

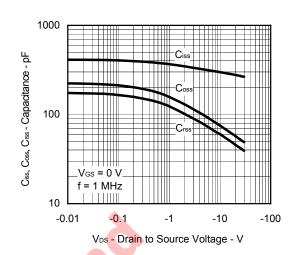
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



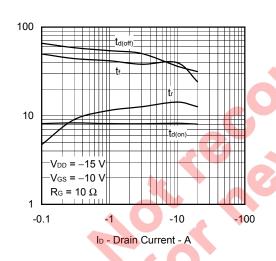
RDS(on) - Drain to Source On-state Resistance - m\Omega

td(on), tr, td(off), tr - Switching Time - ns

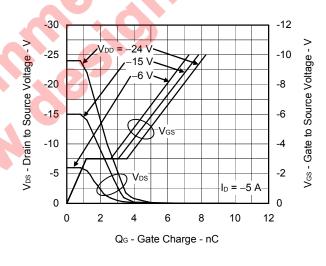
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



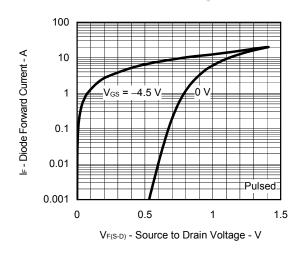
SWITCHING CHARACTERISTICS



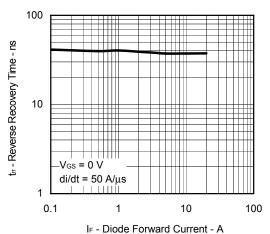
DYNAMIC INPUT/OUTPUT CHARACTERISTICS



SOURCE TO DRAIN DIODE FORWARD VOLTAGE

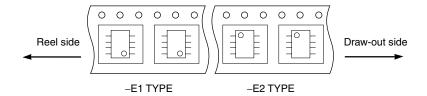


REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT

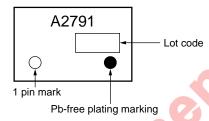


TAPE INFORMATION

There are two types (-E1, -E2) of taping depending on the direction of the device.



MARKING INFORMATION



RECOMMENDED SOLDERING CONDITIONS

The μ PA2791GR should be soldered and mounted under the following recommended conditions.

For soldering methods and conditions other than those recommended below, please contact an NEC Electronics sales representative.

For technical information, see the following website.

Semiconductor Device Mount Manual (http://www.necel.com/pkg/en/mount/index.html)

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	Maximum temperature (Package's surface temperature): 260°C or below	IR60-00-3
	Time at maximum temperature: 10 seconds or less	
	Time of temperature higher than 220°C: 60 seconds or less	
	Preheating time at 160 to 180°C: 60 to 120 seconds	
	Maximum number of reflow processes: 3 times	
	Maximum chlorine content of rosin flux (percentage mass): 0.2% or less	
Partial heating	Maximum temperature (Pin temperature): 350°C or below	P350
	Time (per side of the device): 3 seconds or less	
	Maximum chlorine content of rosin flux: 0.2% (wt.) or less	

Caution Do not use different soldering methods together (except for partial heating).

NEC μ PA2791GR

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